

**Dual N-Channel Enhancement Mode Field Effect Transistor****PRODUCT SUMMARY**

V _{DSS}	I _D	R _{DS(ON)} (mΩ) Max
100V	2.0A	216 @ V _{GS} =10V

FEATURES

- Super high dense cell design for low R_{DS(ON)}.
- Rugged and reliable.
- Surface Mount Package.

**ABSOLUTE MAXIMUM RATINGS (T_A=25°C unless otherwise noted)**

Symbol	Parameter	Limit	Units
V _{DS}	Drain-Source Voltage	100	V
V _{GS}	Gate-Source Voltage	±20	V
I _D	Drain Current-Continuous ^{a e}	T _A =25°C	2.0
		T _A =70°C	1.6
I _{DM}	-Pulsed ^b	13	A
E _{AS}	Single Pulse Avalanche Energy ^d	16	mJ
P _D	Maximum Power Dissipation ^a	T _A =25°C	1.47
		T _A =70°C	0.94
T _J , T _{STG}	Operating Junction and Storage Temperature Range	-55 to 150	°C

THERMAL CHARACTERISTICS

R _{θJA}	Thermal Resistance, Junction-to-Ambient	85	°C/W
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SP2102

Ver 1.0

ELECTRICAL CHARACTERISTICS (T_A=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
OFF CHARACTERISTICS						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	100			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =80V , V _{GS} =0V			1	uA
I _{GSS}	Gate-Body Leakage Current	V _{GS} = ±20V , V _{DS} =0V			±100	nA
ON CHARACTERISTICS						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	1	1.7	2.5	V
R _{DS(ON)}	Drain-Source On-State Resistance	V _{GS} =10V , I _D =1A		173	216	m ohm
g _{FS}	Forward Transconductance	V _{DS} =10V , I _D =1A		2		S
DYNAMIC CHARACTERISTICS ^c						
C _{ISS}	Input Capacitance	V _{DS} =25V, V _{GS} =0V f=1.0MHz		300		pF
C _{OSS}	Output Capacitance			35		pF
C _{RSS}	Reverse Transfer Capacitance			23		pF
SWITCHING CHARACTERISTICS ^c						
t _{D(ON)}	Turn-On Delay Time	V _{DD} =50V I _D =1A		9		ns
t _r	Rise Time			9		ns
t _{D(OFF)}	Turn-Off Delay Time	V _{GS} =10V R _{GEN} = 6 ohm		17		ns
t _f	Fall Time			3.8		ns
Q _g	Total Gate Charge	V _{DS} =50V, I _D =1A, V _{GS} =10V		5		nC
		V _{DS} =50V, I _D =1A, V _{GS} =4.5V		3		nC
Q _{gs}	Gate-Source Charge	V _{DS} =50V, I _D =1A,		0.9		nC
Q _{gd}	Gate-Drain Charge	V _{GS} =10V		1.6		nC
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =2A		0.83	1.2	V
Notes						
a.Surface Mounted on FR4 Board, t ≤ 10sec.						
b.Pulse Test:Pulse Width ≤ 300us, Duty Cycle ≤ 2%.						
c.Guaranteed by design, not subject to production testing.						
d.Starting T _J =25°C, L=0.5mH, V _{DD} = 50V.(See Figure13)						
e.Drain current limited by maximum junction temperature.						

Jan,03,2014

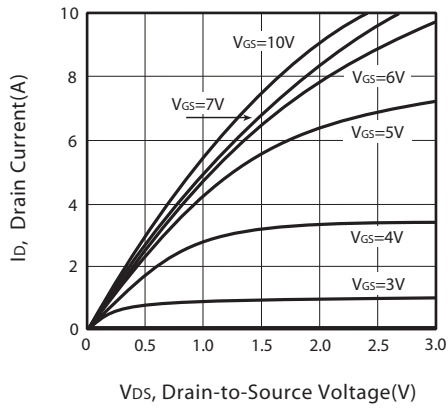


Figure 1. Output Characteristics

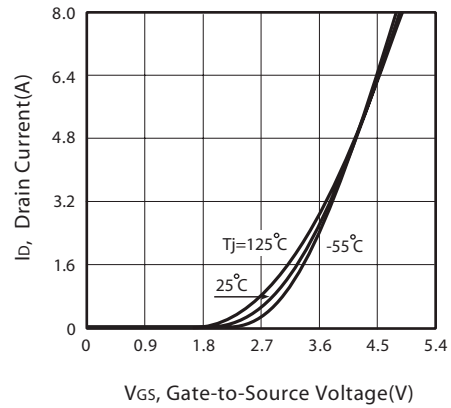


Figure 2. Transfer Characteristics

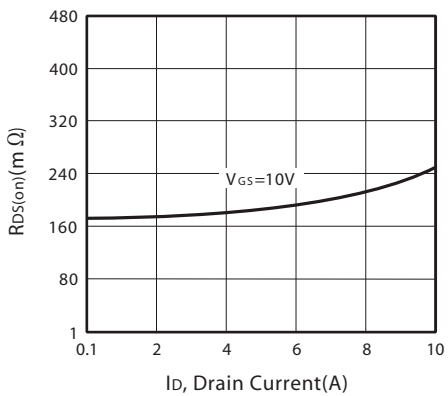


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

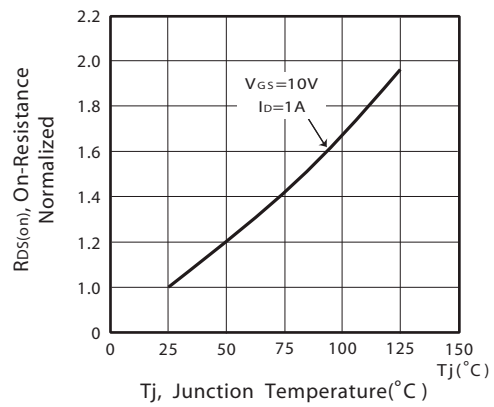


Figure 4. On-Resistance Variation with Drain Current and Temperature

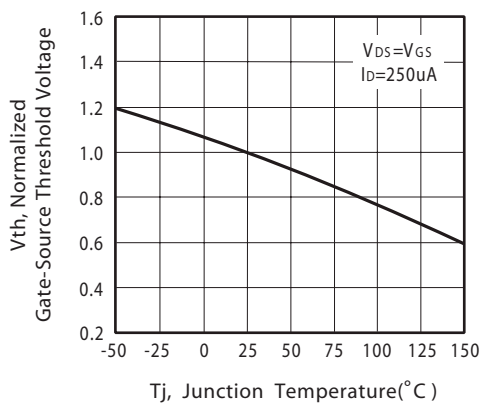


Figure 5. Gate Threshold Variation with Temperature

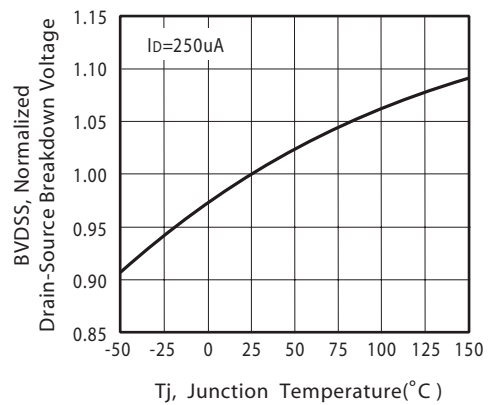


Figure 6. Breakdown Voltage Variation with Temperature

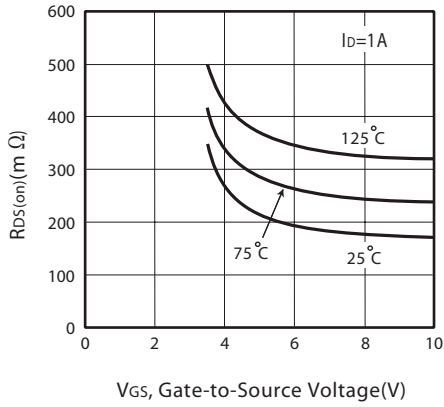


Figure 7. On-Resistance vs. Gate-Source Voltage

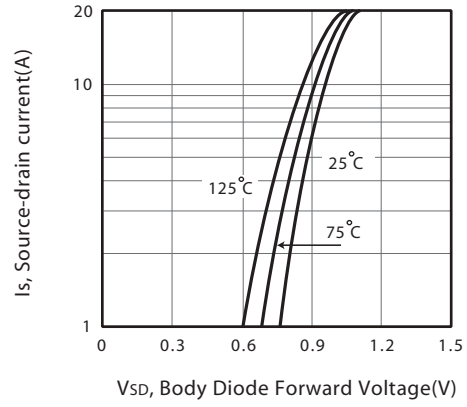


Figure 8. Body Diode Forward Voltage Variation with Source Current

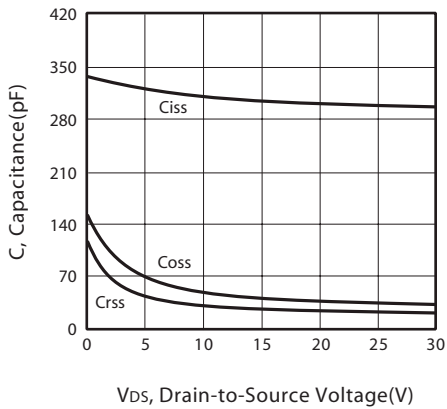


Figure 9. Capacitance

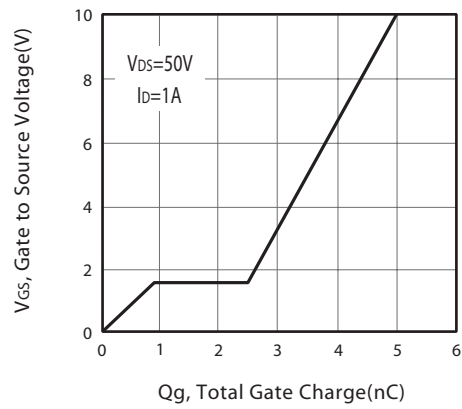


Figure 10. Gate Charge

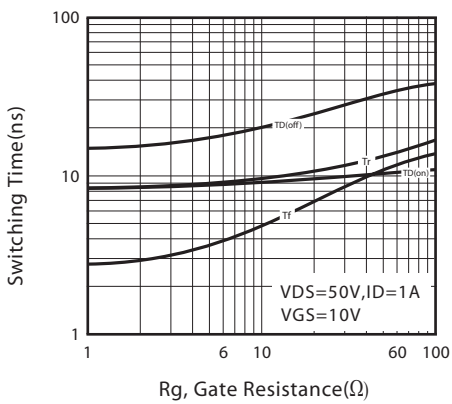


Figure 11. switching characteristics

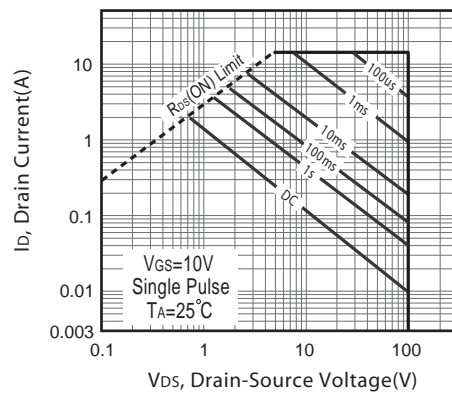
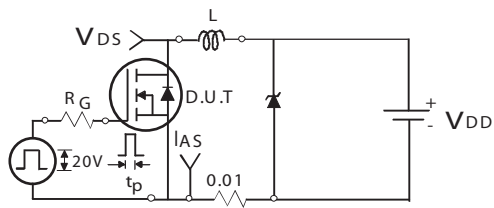
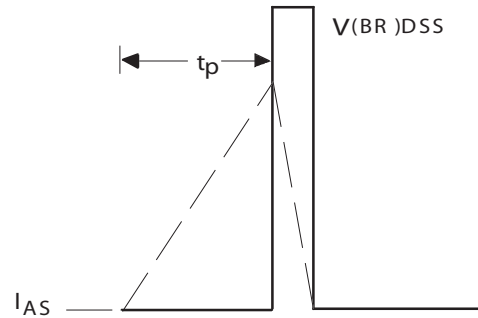


Figure 12. Maximum Safe Operating Area



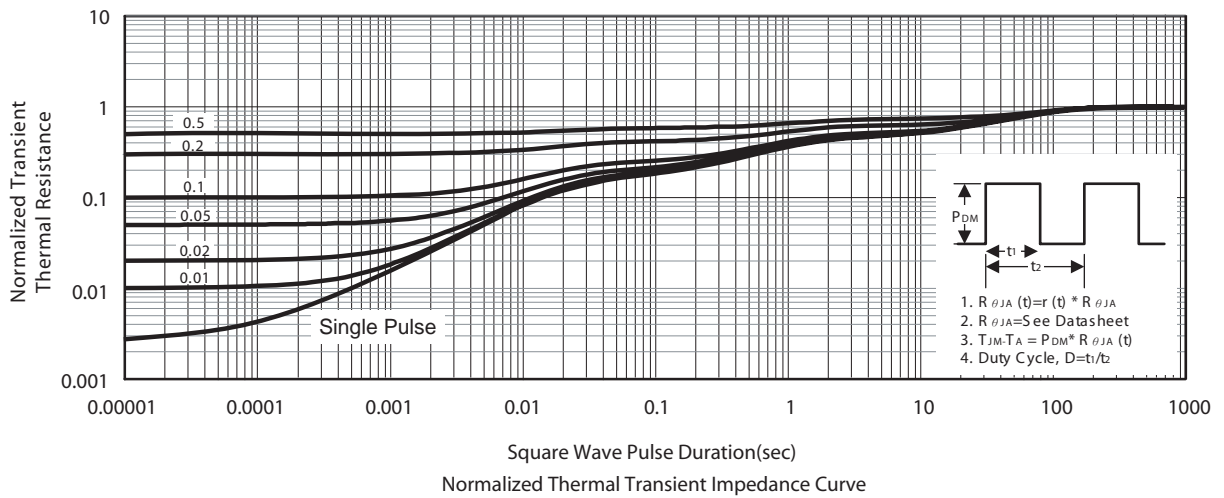
Unclamped Inductive Test Circuit

Figure 13a.



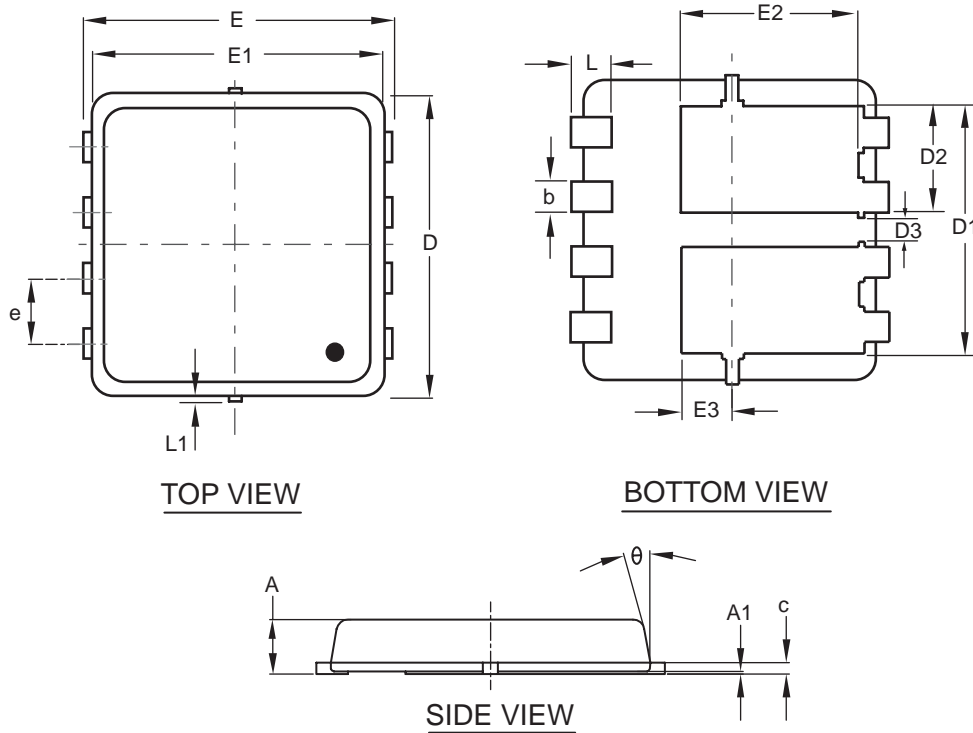
Unclamped Inductive Waveforms

Figure 13b.



PACKAGE OUTLINE DIMENSIONS

DFN 3x3-8L



SYMBOLS	MILLIMETERS		
	MIN	NOM	MAX
A	0.70	0.80	0.90
A1	0.00	—	0.05
b	0.24	0.30	0.35
c	0.10	0.152	0.25
D	3.00 BSC		
D1	2.475 BSC		
D2	1.063 BSC		
D3	0.225 BSC		
E	3.20 BSC		
E1	3.00 BSC		
E2	1.813 BSC		
E3	0.525 BSC		
e	0.65 BSC		
L	0.30	0.40	0.50
L1	0.00	—	0.100
θ	0°	10°	12°

TOP MARKING DEFINITION

